

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/726,595 KIM ET AL.	
		Examiner Christian La Forgia	Art Unit 2131	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0064700 A1	04-2004	Kim et al.	713/170
*	B	US-2003/0081785 A1	05-2003	Boneh et al.	380/277
*	C	US-2003/0179885 A1	09-2003	Gentry et al.	380/277
*	D	US-2003/0182554 A1	09-2003	Gentry et al.	713/171
*	E	US-2003/0041262 A1	02-2003	Kon, Masashi	713/200
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.